

N-CHANNEL SILICON POWER MOSFET

FAP-III B SERIES

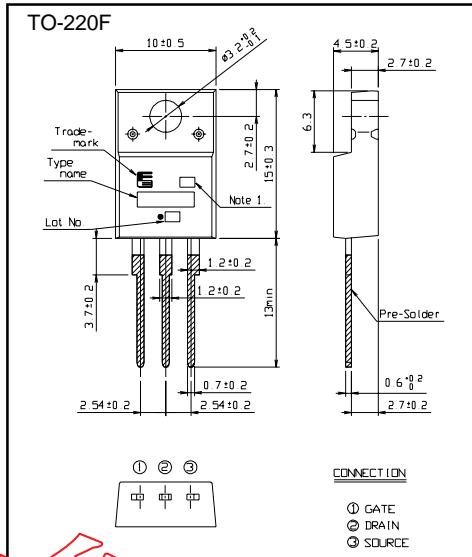
■ Features

- High speed switching
- Low on-resistance
- No secondary breakdown
- Low driving power
- High voltage
- Avalanche-proof

■ Applications

- Switching regulators
- DC-DC converters
- General purpose power amplifier

■ Outline Drawings



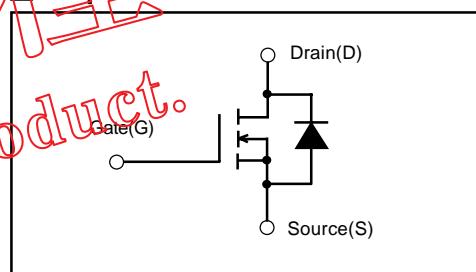
■ Maximum ratings and characteristics

● Absolute maximum ratings ($T_c=25^\circ\text{C}$ unless otherwise specified)

Item	Symbol	Rating	Unit	Remarks
Drain-source voltage	V_{DS}	30	V	
Continuous drain current	I_D	±35	A	
Pulsed drain current	$I_{D(\text{pulse})}$	±140	A	
Gate-source peak voltage	V_{GS}	±16	V	
Maximum avalanche energy	E_A	129.3	mJ	*
Maximum power dissipation	P_D	20	W	
Operating and storage temperature range	T_{ch}	-150 to +150	°C	
	T_{stg}	-55 to +150	°C	

*1 $L=0.70\text{mH}$, $V_{CC}=12\text{V}$

● Equivalent circuit schematic



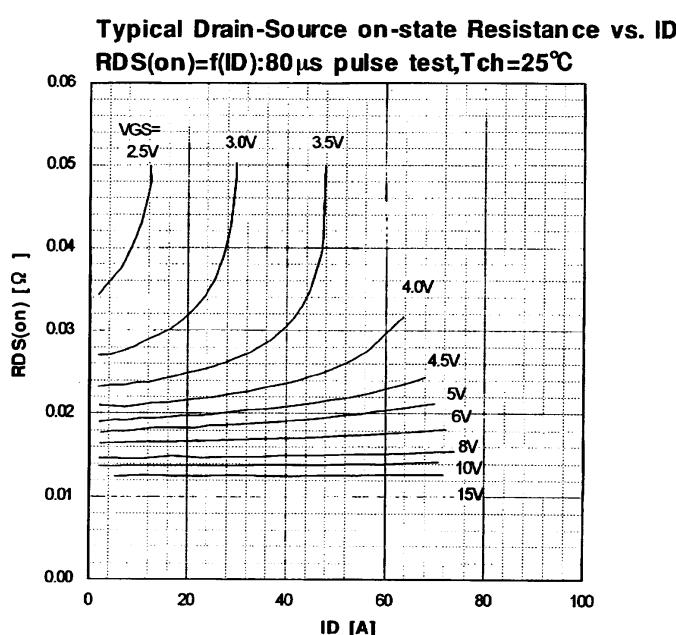
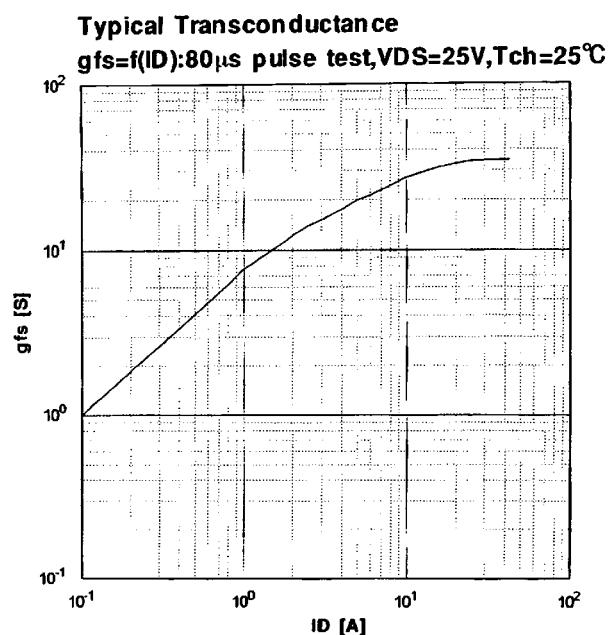
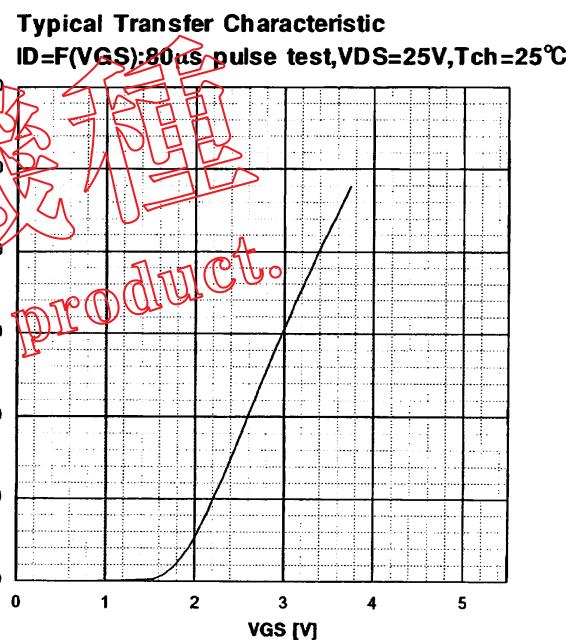
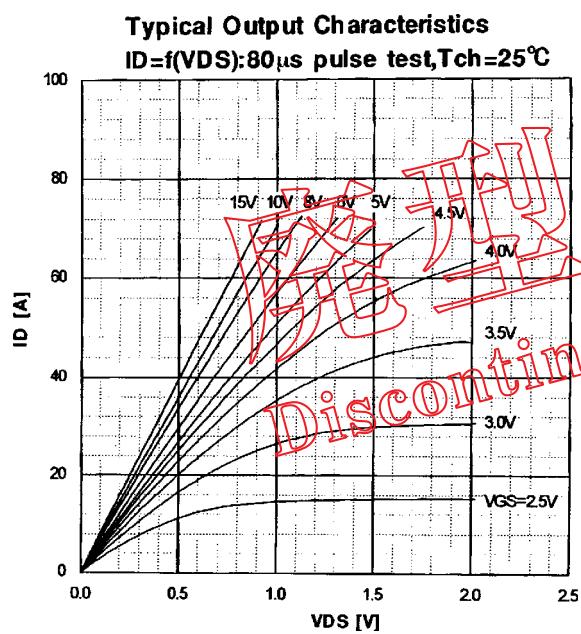
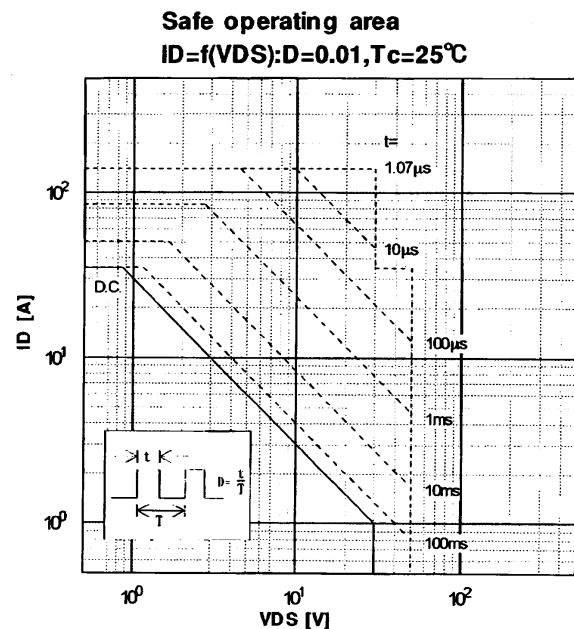
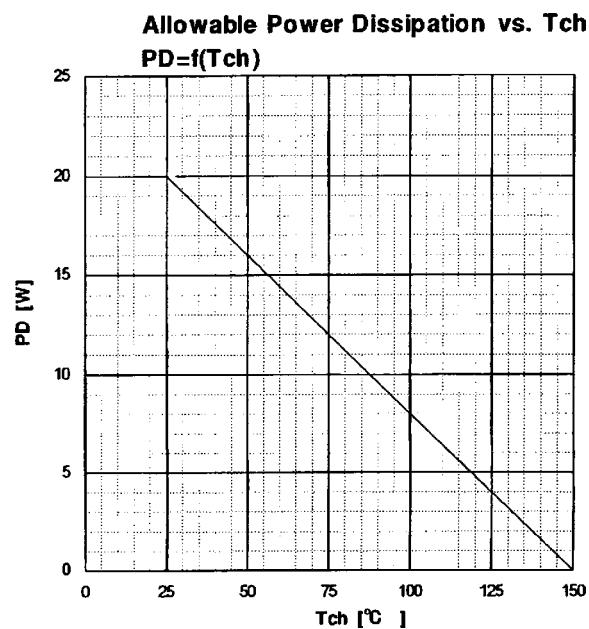
● Electrical characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified)

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-source breakdown voltage	$V_{(BR)DSS}$	$I_D=1\text{mA}$ $V_{GS}=0\text{V}$	30			V
Gate threshold voltage	$V_{GS(\text{th})}$	$I_D=1\text{mA}$ $V_{DS}=V_{GS}$	1.0	1.5	2.0	V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=30\text{V}$ $V_{GS}=0\text{V}$	10	500	500	μA
		$T_{ch}=25^\circ\text{C}$	0.2	1.0	1.0	mA
Gate-source leakage current	I_{GS}	$V_{GS}=\pm 16\text{V}$ $V_{DS}=0\text{V}$	10	100	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$I_D=17.5\text{A}$ $V_{GS}=10\text{V}$	22	30	30	$\text{m}\Omega$
		$V_{GS}=4\text{V}$	14	20	20	$\text{m}\Omega$
Forward transconductance	g_{fs}	$I_D=17.5\text{A}$ $V_{DS}=25\text{V}$	16	33	33	S
Input capacitance	C_{iss}	$V_{DS}=25\text{V}$		1100	1650	
Output capacitance	C_{oss}	$V_{GS}=0\text{V}$		550	830	
Reverse transfer capacitance	C_{rss}	$f=1\text{MHz}$		240	360	pF
Turn-on time	$t_{d(on)}$	$V_{CC}=15\text{V}$ $R_G=10\ \Omega$	9	15		
	t_r	$I_D=35\text{A}$	15	23		
Turn-off time	$t_{d(off)}$	$V_{GS}=10\text{V}$	75	115		
	t_f		50	75		ns
Avalanche capability	I_{AV}	$L=100\mu\text{H}$ $T_{ch}=25^\circ\text{C}$	35			A
Diode forward on-voltage	V_{SD}	$I_F=2\times I_{DR}$ $V_{GS}=0\text{V}$ $T_{ch}=25^\circ\text{C}$		0.98	1.71	V
Reverse recovery time	t_{rr}	$I_F=2\times I_{DR}$ $V_{GS}=0\text{V}$		50		ns
Reverse recovery charge	Q_{rr}	$-di/dt=100\text{A}/\mu\text{s}$ $T_{ch}=25^\circ\text{C}$		0.08		μC

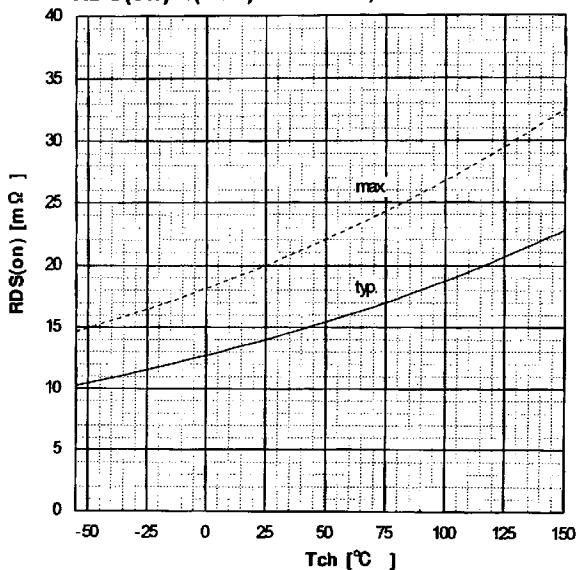
● Thermal characteristics

Item	Symbol	Min.	Typ.	Max.	Units
Thermal resistance	$R_{th(ch-c)}$			6.25	$^\circ\text{C}/\text{W}$
	$R_{th(ch-a)}$			62.5	$^\circ\text{C}/\text{W}$

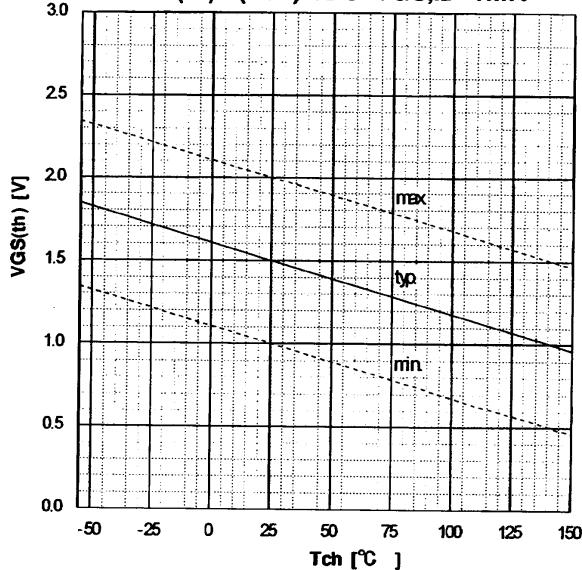
Characteristics



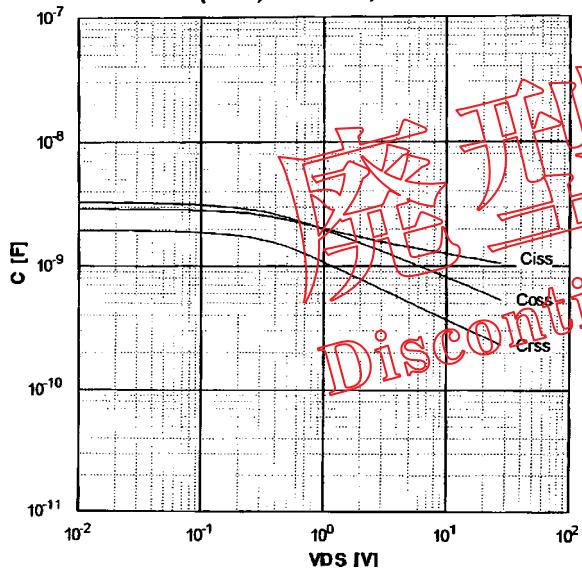
Drain-Source On-state Resistance vs. Tch
 $R_{DS(on)} = f(Tch)$: ID=17.5A, VGS=10V



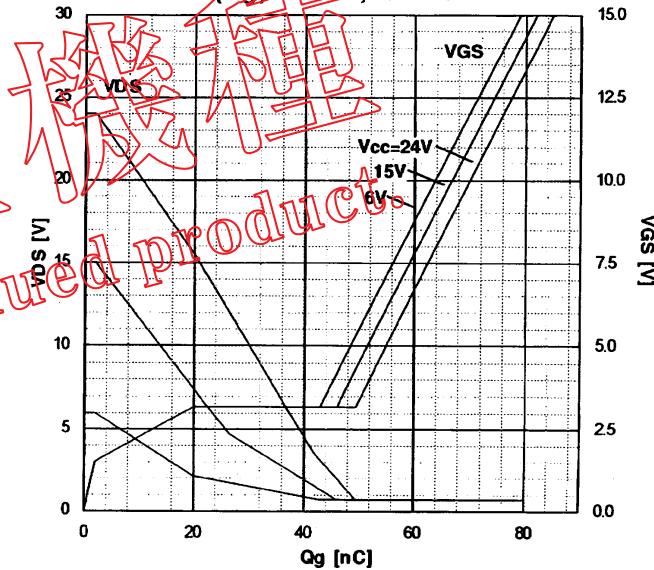
Gate Threshold Voltage vs. Tch
 $V_{GS(th)} = f(Tch)$: VDS=VGS, ID=1mA



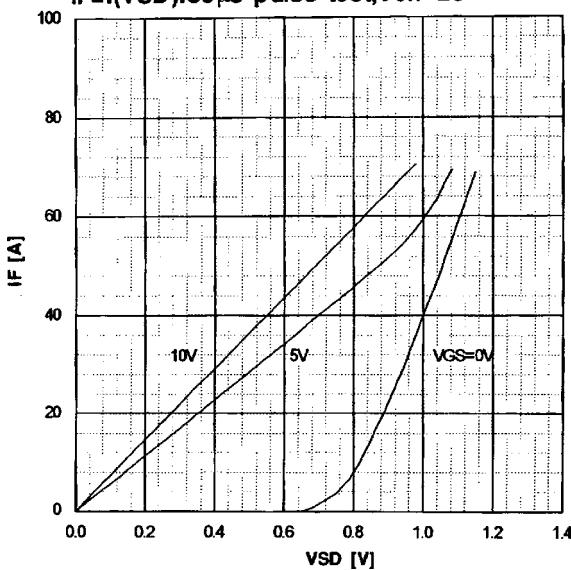
Typical Capacitances vs. VDS
 $C = f(VDS)$: VGS=0V, f=1MHz



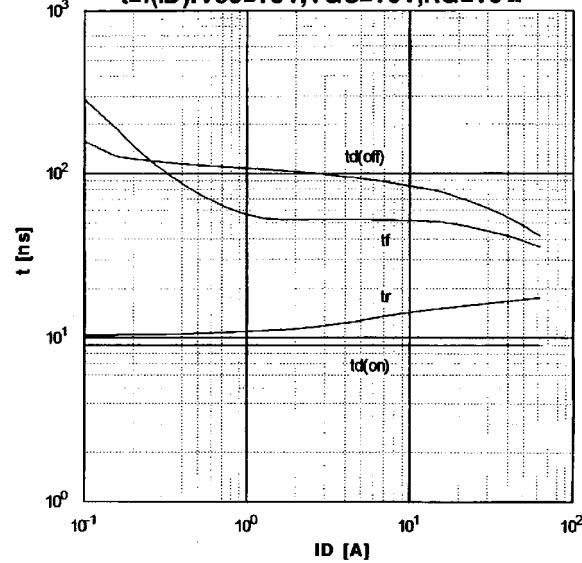
Typical Gate Charge Characteristics
 $VGS = f(Qg)$: ID=35A, Tch=25°C



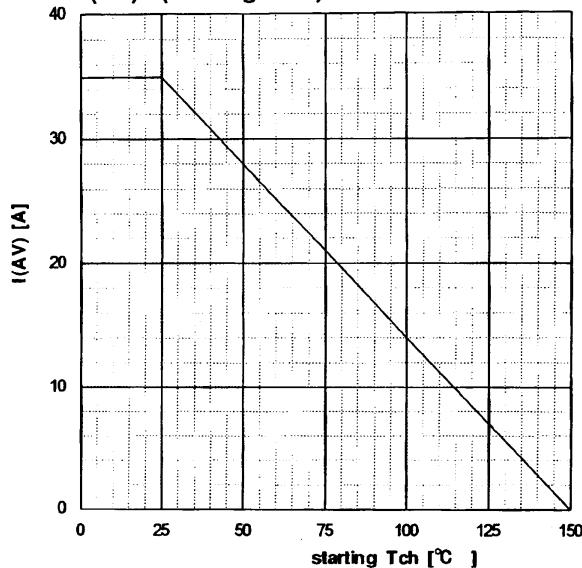
Typical Forward Characteristics of Reverse Diode
 $IF = f(VSD)$: 80μs pulse test, Tch=25°C



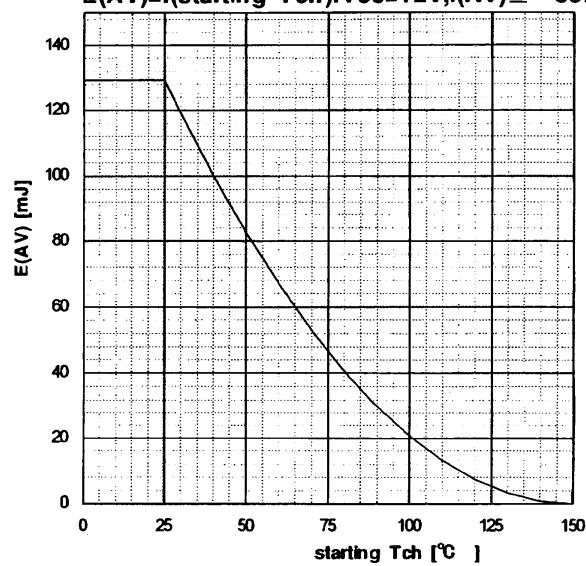
Typical Switching Characteristics vs. ID
 $t = f(ID)$: Vcc=15V, VGS=10V, RG=10Ω



Maximum Avalanche Current vs. starting Tch
 $I(AV)=f(\text{starting Tch})$



Maximum Avalanche Energy vs. starting Tch
 $E(AV)=f(\text{starting Tch}): Vcc=12V, I(AV) \leq 35A$



Transient thermal impedance
 $Z_{th}(ch-c)=f(t)$ parameter: $D=t/T$

